

**DEPARTMENT OF DEFENCE PRODUCTION (DDP) /
DIRECTORATE GENERAL OF QUALITY ASSURANCE (DGQA)**

12575/DGQA/DTIS/EMI/EMC TEST FACILITY

07 Nov 2025

CORRIGENDUM 3

**RFP FOR DEVELOPMENT, OPERATION AND MAINTENANCE OF DEFENCE TESTING
INFRASTRUCTURE (DTI) FOR ELECTROMAGNETIC INTERFERENCE (EMI) AND
ELECTROMAGNETIC COMPATIBILITY (EMC) TESTS UNDER THE DEFENCE TESTING
INFRASTRUCTURE SCHEME (DTIS)**

1. Refer to the Request for Proposal (RFP) for Development of Defence Testing Infrastructure (DTI) for Electromagnetic Interference (EMI) and Electromagnetic Compatibility (EMC) under the Defence Testing Infrastructure Scheme (DTIS), issued on 19.09.2025.
2. Kindly refer to the corrected details provided below, which shall be considered for all purposes related to this Request for Proposal (RFP). The corresponding information contained in the original RFP document is hereby superseded.

Sr. No.	Section/Clause No.	Description as per Original RFP	Revised Description / Corrected Details	Remarks
1	SECTION – II: INSTRUCTIONS TO BIDDER (ITB)	Para 17.3 Tests and testing capability, range and capacity	Revised Para 17.3 is appended below	Revised Para 17.3 as appended below to be considered
2	Appendix-M	Appendix – M: List of Tests, Test Equipment and Standards	Revised Appendix – M is appended below	Revised Appendix-M as appended below to be considered

Sr. No.	Section/Clause No.	Description as per Original RFP	Revised Description / Corrected Details	Remarks
3	Appendix-P (Schedule – H: Services)	Appendix-P (Schedule – H: Services)	Revised Appendix-P (Schedule – H: Services) is appended below	Revised Appendix-P (Schedule – H: Services) as appended below to be considered
4	Appendix – Q: DTI Scheme Guidelines and Amendments	Appendix – Q: DTI Scheme Guidelines and Amendments	No change. Attached again for reference	Appendix – Q: DTI Scheme Guidelines and Amendments, attached again for reference

3. The changes are elaborated below for your reference and necessary action. All other terms and conditions of the RFP shall remain unchanged.

SECTION – II: INSTRUCTIONS TO BIDDER (ITB)

Tests and testing capability, range and capacity

17.3

As part of the tests and testing capabilities scoring criteria, Bidders will be required to provide details of the tests they will be providing as part of their DTIS facility. The marks will be awarded based on the test range, capability and capacity offered by the bidders for each test.

- a. Range: It refers to the operating range of the test equipment for each test. The bidder offering the highest range for a particular test will be awarded maximum marks of 0.3.
- b. Capacity: It refers to the number of tests that can be carried out per year using the test equipment. The bidder offering the highest capacity for a particular test will be awarded maximum marks of 0.3.
- c. Capability: It refers to the size of the equipment being tested. The bidder offering the highest capability for a particular test will be awarded maximum marks of 0.4.

Table 1 : Technological Capabilities

Parameter	Max Marks	Scoring
Proposed mandatory tests (total 30 tests), as mentioned in Appendix M below	<ul style="list-style-type: none"> • 21 marks • 0.7 marks per test Signed Undertaking by the bidder to be submitted	<ul style="list-style-type: none"> • Maximum marks for each test will be allocated to the bidder offering the maximum range, capability and capacity for the test • The marks provided to other bidders will be proportionate to its proposed range and capacity for each test as compared to that of the highest range, capability and capacity proposed by any bidder • Calculation of the score is shown below this table along with an example
Tests proposed in addition to the	<ul style="list-style-type: none"> • 9 marks • 0.5 marks per test 	<ul style="list-style-type: none"> • Maximum marks for each test will be allocated to the bidder offering the maximum range, capability and capacity for the test

mandatory tests (total 18 additional tests), as mentioned in Appendix-M below	<ul style="list-style-type: none"> • Signed Undertaking by the bidder to be submitted 	<ul style="list-style-type: none"> • The marks provided to other bidders will be proportionate to its proposed range and capacity for each test as compare to that of the highest range, capability and capacity proposed by any bidder • Calculation of the score is shown below this table along with an example
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Total technical score for mandatory tests = \sum Technical score of each mandatory test

Technical score for each mandatory test = $\{0.3 * (\text{Range of the test proposed by the bidder} / \text{maximum range proposed by any bidder}) + 0.3 * (\text{Capacity of the test proposed by the bidder} / \text{maximum capacity proposed by any bidder}) + 0.4 * (\text{Capability of the test proposed by the bidder} / \text{maximum capability proposed by any bidder})\} \times 0.7$

For example, let us say, for High Intensity Radiated Field (HIRF) test the maximum capacity proposed by any bidder is 1000 units per year. The highest frequency range for the test is 20 MHz to 40 MHz. The highest size/dimension of equipment being proposed to be tested for a radar of 1000 cubic-feet. Now if Bidder A proposes to provide an HIRF test for frequency range of 20 MHz to 30 MHz with an annual capacity of 900 units per year for a radar of 500 cubic feet, the technical score for the bidder for HIRF test will be given by:

Technical score for HIRF test for Bidder A = $\{0.3*(10/20) + 0.3*(900/1000) + 0.4*(500/1000)\} * 0.7 = \{0.15+ 0.27+0.20\} * 0.7 = 0.62* 0.7 = 0.434$

Similarly, total technical score for additional tests = \sum Technical score of each additional test

Technical score for each additional test = $\{0.3 * (\text{Range of the test proposed by the bidder} / \text{maximum range proposed by any bidder}) + 0.3 * (\text{Capacity of the test proposed by the bidder} / \text{maximum capacity proposed by any bidder}) + 0.4 * (\text{Capability of the test proposed by the bidder} / \text{maximum capability proposed by any bidder})\} \times 0.5$

APPENDIX – M: LIST OF TESTS, TEST EQUIPMENT AND STANDARDS

The tests proposed to be undertaken at the DTI facility of EMI / EMC testing are given in the table below.

The tests are categorized as mandatory tests and additional tests. Mandatory tests comprise of tests which are required to be part of the DTIS facility proposed by the bidder and additional tests comprise of tests which are good to have as part of the proposed DTIS facility or proposed additionally to the mandatory tests.

I. Mandatory Tests

A. Pre-Compliance Test

1. Military EMC Chambers
2. ESD (Electrostatic discharge) testing
3. EMC testing for E-marking on Sub-assemblies & whole vehicles
4. Testing to LVD (Low voltage directive), MD (Machinery directive) & RED (Radio equipment directive)
5. Conducted & radiated electromagnetic immunity / Conducted & radiated continuous immunity tests / Susceptibility Testing
 - 5.1 MIL-STD-461 (F/G) Conducted Immunity Tests
 - 5.1.1 CS101: Conducted Susceptibility / Power Leads / 30 Hz – 150 kHz
 - 5.1.2 CS103: Conducted Susceptibility, Antenna Port, Intermediation, 15 KHz to 10 GHz
 - 5.1.3 CS104: Conducted Susceptibility, Antenna Port, Rejection of undesired signals, 30 Hz to 20 GHz
 - 5.1.4 CS105: Conducted Susceptibility, Antenna Port Cross-Modulation, 30 Hz to 20 GHz
 - 5.1.5 CS109: Conducted Susceptibility, Structure Current, 60 Hz to 100 KHz
 - 5.1.6 CS114: Conducted Susceptibility / Bulk Cable Injection / 10 kHz – 200 MHz
 - 5.1.7 CS115: Conducted Susceptibility / Bulk Cable Injection / Impulse Excitation
 - 5.1.8 CS116: Conducted Susceptibility / Damped Sinusoidal Transients / Cables & Power Leads / 10 kHz to 100 MHz
 - 5.1.9 CS117: Conducted Susceptibility, Lightning Induced Transients, Cable and Power Leads
 - 5.1.10 CS118: Conducted Susceptibility, Personnel Borne Electrostatic Discharge
 - 5.2 MIL-STD-461 (F/G) Radiated Immunity Tests

5.2.1 RS101: Radiated Susceptibility / Magnetic Fields / 30 Hz – 100 kHz

5.2.2 RS103: Radiated Susceptibility / Electric Field / 2 MHz – 40 GHz

5.2.3 RS105: Radiated Susceptibility, Transient Electromagnetic field

6. Conducted & radiated electromagnetic emission Testing

6.1 MIL-STD-461 (F/G) Conducted Emission Tests

6.1.1 CE101: Conducted Emissions / Audio Frequency Power Leads / 30 Hz – 10 kHz

6.1.2 CE102: Conducted Emissions / RF potential Power Leads / 10 kHz – 10 MHz

6.1.3 CE106: Conducted Emissions, Antenna Port 10 KHz to 40 GHz

6.2 MIL-STD-461 (F/G) Radiated Emission Tests

6.2.1 RE101: Radiated Emissions / Magnetic Field / 30 Hz – 100 KHz

6.2.2 RE102: Radiated Emissions / Electric Field / 10 kHz – 18 GHz (40 GHz Optional/Phase II)

6.2.3 RE103: Radiated Emissions, Antenna Spurious and Harmonic Outputs, 10 KHz to 40 GHz

B. Acceptance & Qualification Tests

7. Lightning Induced Transient Susceptibility

8. Radio Frequency Susceptibility (Radiated & Conducted)

9. High Intensity radiated Fields

10. Magnetic effect

11. Voltage Spike

12. Induced signal Susceptibility

13. Measuring Automated Software

II. Additional Tests

C. Miscellaneous Tests

1. Shielding effectiveness tests for various materials

2. Bulk injection tests

3. Audio Frequency Conducted Susceptibility

4. Burst & Voltage Dip test
5. Radio frequency equipment electromagnetic disturbance tests
6. Electromagnetic compatibility of multimedia equipment – Emission requirements
7. SPD Tests
8. Harmonics and Flicker test
9. Electrical Fast Transients tests
10. High Intensity Radiated Field (HIRF) tests
11. Electrical surge tests
12. Bonding and Grounding tests
13. Modulated stirred tests
14. Mode tuned tests
15. Measurement and validation of RF tests
16. Energy efficiency tests
17. Pulse magnetic field test
18. Magnetic field continuous immunity tests

The following certifications and standards would be required to be adhered to by envisioned test facility:

1. AS 6081
2. MIL-STD-461 F/G
3. MIL 790G
4. BIS standards
5. ISO standards
6. CISPR tests
7. COTS standards

All the mandatory and additional tests needs to be as per MIL STD – 461 F/G and the proposed EMI/EMC test facility should be NABL accredited as per ISO/IEC 17025. The proposed test facility to be comprised of:

1. RF-Shielded Room & Related Components, Anechoic Absorber Materials, and Baseline Chamber Equipment. The minimum size of shielded anechoic chamber should be 10m x 10m x 10m.
2. Conducted & Radiated Emissions Measurement Equipment
3. Conducted & Radiated susceptibility Measurement Equipment, among others

An indicative list of test equipment for the proposed testing facility is provided below. Bidders need to specify what would be the capacity and range of the test equipment that they will be offering for the mandatory and additional tests. The envisioned test facility should adhere to the standards listed in the RFP, including but not limited to AS 6081, MIL-STD-461 F/G, MIL 790G, BIS standards, ISO standards, CISPR

tests, and COTS standards. Equipment required to conduct tests as established in MIL-STD-461 F/G must be procured for the testing lab under DTIS. Each equipment must meet IS or equivalent international standards.

Test equipment	
1)	Active rod-monopole Antenna
2)	Active transmitter & receiver loop antennas
3)	AF Signal Generators
4)	Anechoic Absorber Materials
5)	Anechoic Chambers
6)	Artificial Mains Network
7)	Attenuators
8)	Automated EMC Test Software
9)	Baseline Chamber Equipment. Supply RF lines filters
10)	Biconical Antennas
11)	Bulk Current Injection Systems
12)	Centralized Data Acquisition System.
13)	Comb generator source
14)	Compact EMC Chambers
15)	Copper test bench
16)	Coupling/Decoupling Networks (CDNs)
17)	Current Probes
18)	Curve Tracers
19)	DC Blocker
20)	DC power supply up to 60V
21)	Die Comparator Station
22)	Digital Megger
23)	Digital Milliohm meter
24)	Digital Mustimeters
25)	Directional Coupler 1
26)	Directional Coupler 2
27)	Double ridge horn antenna
28)	EFT/Burst Generator
29)	Electrostatic Discharge (ESD) gun and calibration target, RC combinations
30)	EM Absorbing clamp
31)	EM Field Probes
32)	EMC automation software
33)	EMI Automation software
34)	EMI Receivers
35)	EMP Test Generators
36)	Energy Dispersive X-ray Spectrometer (EDS)
37)	ESD Simulators
38)	Etching Station
39)	External pre-amplifier 1
40)	External pre-amplifier 2
41)	Fiber optics Trans receiver
42)	Functional Testers
43)	Grinding and Polishing Systems

- 44) Ground Continuity Testers
- 45) GTEM Cells
- 46) Harmonics Analyzer
- 47) Heated Reflux Solvent Tester
- 48) Helmholtz Coils
- 49) High Power RF Amplifiers
- 50) High voltage DC Power supply
- 51) HIRF Chamber
- 52) Horn Antennas
- 53) Immunity Antennas & Masts
- 54) Infrared Thermography Camera
- 55) LCR Meters
- 56) Lightning Pulse Simulators
- 57) Lightning/Transient Generators
- 58) LISN
- 59) Log-Periodic Antennas
- 60) Magnetic Field Meters
- 61) Magnetic Immunity Testers
- 62) Measurement of Q, Inductance & Capacitance
- 63) Measurement setup for Effective radiated power
- 64) Measuring equipment like oscilloscope, signal generators, logic analyzer, spectrum analyzer etc.
- 65) Micro Thermal Imager
- 66) Microsectioning Equipment
- 67) Milliohm Meters
- 68) Mode Stirrer Setup
- 69) Near-field Probes
- 70) Optical Microscope
- 71) Oscilloscopes
- 72) Parallel Lapping Station
- 73) Parametric Testers
- 74) Power Amplifiers
- 75) Power Analyzers
- 76) Power Source Simulator
- 77) Pre-Amplifiers
- 78) Precision Multimeters
- 79) Profilometer
- 80) Programmable AC/DC Loads
- 81) RE 101 loop sensors
- 82) Reverberation Chambers
- 83) RF Amplifiers
- 84) RF Attenuators – 10,20 & 30dB
- 85) RF Cables
- 86) RF Current probe
- 87) RF/ Microwave signal generator
- 88) RF-Shielded Room & Related Components
- 89) Safety Analyzer
- 90) Scanning Acoustic Microscope (SAM)
- 91) Scanning Electron Microscope (SEM)

92)	Shielded Rooms
93)	Shielding Effectiveness Test Setup
94)	Signal Generators
95)	SPD Test Bench
96)	Spectrum Analyzer
97)	Spherical dipole antenna
98)	Spike Generators
99)	Storage Oscilloscopes
100)	Surge generator for MIL-STD 1275E
101)	Temperature/Humidity Chambers
102)	Time and Frequency Measurement
103)	Transient Generators as per MIL
104)	Transient limiter
105)	Variable AC Power supply
106)	Variance
107)	Vector Network analyser
108)	Vibration Test Setup
109)	Voltage Dip Simulator
110)	XRF Analyzer

To,

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DQA (WP)/ DDPDGQA
Floor 6, “B” Block,
MoD Complex, Africa Avenue,
New Delhi-110023

Sub: Bid for Development, Operation and Management of Defence Testing Infrastructure (DTI) for Electromagnetic Interference (EMI) Electromagnetic Compatibility (EMC) under the Defence Testing Infrastructure Scheme (DTIS)

Dear Sir,

We (name of the bidder) propose to undertake the following mandatory and additional tests for the proposed DTI facility. The key information of the tests along with the technical details are being submitted in the DPR.

I. Mandatory Tests

S. No	Name of test	Capacity	Range	Capability	Proposed Equipment
A. Pre-Compliance Test					
1.	Military EMC Chambers				
2.	ESD (Electrostatic discharge) testing				

S. No	Name of test	Capacity	Range	Capability	Proposed Equipment
3.	EMC testing for E-marking on Sub-assemblies & whole vehicles				
4.	Testing to LVD (Low voltage directive), MD (Machinery directive) & RED (Radio equipment directive)				
5.	Conducted & radiated electromagnetic immunity / Conducted & radiated continuous immunity tests / Susceptibility Testing				
5.1	MIL-STD-461 (F/G) Conducted Immunity Tests				
5.1.1	CS101: Conducted Susceptibility / Power Leads / 30 Hz – 150 kHz				
5.1.2	CS103: Conducted Susceptibility, Antenna Port, Intermediation, 15 KHz to 10 GHz				
5.1.3	CS104: Conducted Susceptibility, Antenna Port, Rejection of undesired signals, 30 Hz to 20 GHz				
5.1.4	CS105: Conducted Susceptibility, Antenna Port Cross-Modulation, 30 Hz to 20 GHz				
5.1.5	CS109: Conducted Susceptibility, Structure Current, 60 Hz to 100 KHz				
5.1.6	CS114: Conducted Susceptibility / Bulk Cable Injection / 10 kHz – 200 MHz				
5.1.7	CS115: Conducted Susceptibility / Bulk Cable Injection / Impulse Excitation				

S. No	Name of test	Capacity	Range	Capability	Proposed Equipment
5.1.8	CS116: Conducted Susceptibility / Damped Sinusoidal Transients / Cables & Power Leads / 10 kHz to 100 MHz				
5.1.9	CS117: Conducted Susceptibility, Lightning Induced Transients, Cable and Power Leads				
5.1.10	CS118: Conducted Susceptibility, Personnel Borne Electrostatic Discharge				
5.2	MIL-STD-461 (F/G) Radiated Immunity Tests				
5.2.1	RS101: Radiated Susceptibility / Magnetic Fields / 30 Hz – 100 kHz				
5.2.2	RS103: Radiated Susceptibility / Electric Field / 2 MHz – 40 GHz				
5.2.3	RS105: Radiated Susceptibility, Transient Electromagnetic field				
6.	Conducted & radiated electromagnetic emission Testing				
6.1	MIL-STD-461 (F/G) Conducted Emission Tests				
6.1.1	CE101: Conducted Emissions / Audio Frequency Power Leads / 30 Hz – 10 kHz				
6.1.2	CE102: Conducted Emissions / RF potential Power Leads / 10 kHz – 10 MHz				
6.1.3	CE106: Conducted Emissions, Antenna Port 10 KHz to 40 GHz				
6.2	MIL-STD-461 (F/G) Radiated Emission Tests				

S. No	Name of test	Capacity	Range	Capability	Proposed Equipment
6.2.1	RE101: Radiated Emissions / Magnetic Field / 30 Hz – 100 KHz				
6.2.2	RE102: Radiated Emissions / Electric Field / 10 kHz – 18 GHz (40 GHz Optional/Phase II)				
6.2.3	RE103: Radiated Emissions, Antenna Spurious and Harmonic Outputs, 10 KHz to 40 GHz				
B. Acceptance & Qualification Tests					
7	Lightning Induced Transient Susceptibility				
8	Radio Frequency Susceptibility (Radiated & Conducted)				
9	High Intensity radiated Fields				
10	Magnetic effect				
11	Voltage Spike				
12	Induced signal Susceptibility				
13	Measuring Automated Software				

II. Additional Tests

S. No	Name of test	Capacity	Range	Capability	Proposed Equipment
1	Shielding effectiveness tests for various materials				
2	Bulk injection tests				
3	Audio Frequency Conducted Susceptibility				
4	Burst & Voltage Dip test				

S. No	Name of test	Capacity	Range	Capability	Proposed Equipment
5	Radio frequency equipment electromagnetic disturbance tests				
6	Electromagnetic compatibility of multimedia equipment – Emission requirements				
7	SPD Tests				
8	Harmonics and Flicker test				
9	Electrical Fast Transients tests				
10	High Intensity Radiated Field (HIRF) tests				
11	Electrical surge tests				
12	Bonding and Grounding tests				
13	Modulated stirred tests				
14	Mode tuned tests				
15	Measurement and validation of RF tests				
16	Energy efficiency tests				
17	Pulse magnetic field test				
18	Magnetic field continuous immunity tests				
Additional tests proposed by bidder which are not mentioned in the RFP					
19					
20					
..					
..					
..					
..					
..					

Yours Faithfully,

Date: (signature, name and designation of the Authorised signatory)

Place: Name and seal of the Bidder/ Lead Member

APPENDIX P (SCHEDULE – H: SERVICES)

The following testing services are proposed to be undertaken at the Project across different stages viz Research & Development (R&D), Manufacturing, Acceptance and Maintenance, Repair & Operations (MRO), as applicable.

I. Mandatory Tests

A. Pre-Compliance Test

1. Military EMC Chambers
2. ESD (Electrostatic discharge) testing
3. EMC testing for E-marking on Sub-assemblies & whole vehicles
4. Testing to LVD (Low voltage directive), MD (Machinery directive) & RED (Radio equipment directive)
5. Conducted & radiated electromagnetic immunity / Conducted & radiated continuous immunity tests / Susceptibility Testing
 - 5.1 MIL-STD-461 (F/G) Conducted Immunity Tests
 - 5.1.1 CS101: Conducted Susceptibility / Power Leads / 30 Hz – 150 kHz
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 - 5.1.7 CS115: Conducted Susceptibility / Bulk Cable Injection / Impulse Excitation
 - 5.1.8 CS116: Conducted Susceptibility / Damped Sinusoidal Transients / Cables & Power Leads / 10 kHz to 100 MHz
 - 5.1.9 CS117: Conducted Susceptibility, Lightning Induced Transients, Cable and Power Leads
 - 5.1.10 CS118: Conducted Susceptibility, Personnel Borne Electrostatic Discharge

- 5.2 MIL-STD-461 (F/G) Radiated Immunity Tests
 - 5.2.1 RS101: Radiated Susceptibility / Magnetic Fields / 30 Hz – 100 kHz
 - 5.2.2 RS103: Radiated Susceptibility / Electric Field / 2 MHz – 40 GHz
 - 5.2.3 RS105: Radiated Susceptibility, Transient Electromagnetic field
- 6. Conducted & radiated electromagnetic emission Testing
 - 6.1 MIL-STD-461 (F/G) Conducted Emission Tests
 - 6.1.1 CE101: Conducted Emissions / Audio Frequency Power Leads / 30 Hz – 10 kHz
 - 6.1.2 CE102: Conducted Emissions / RF potential Power Leads / 10 kHz – 10 MHz
 - 6.1.3 CE106: Conducted Emissions, Antenna Port 10 KHz to 40 GHz
 - 6.2 MIL-STD-461 (F/G) Radiated Emission Tests
 - 6.2.1 RE101: Radiated Emissions / Magnetic Field / 30 Hz – 100 KHz
 - 6.2.2 RE102: Radiated Emissions / Electric Field / 10 kHz – 18 GHz (40 GHz Optional/Phase II)
 - 6.2.3 RE103: Radiated Emissions, Antenna Spurious and Harmonic Outputs, 10 KHz to 40 GHz

B. Acceptance & Qualification Tests

- 7. Lightning Induced Transient Susceptibility
- 8. Radio Frequency Susceptibility (Radiated & Conducted)
- 9. High Intensity radiated Fields
- 10. Magnetic effect
- 11. Voltage Spike
- 12. Induced signal Susceptibility
- 13. Measuring Automated Software

II. Additional Tests

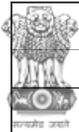
C. Miscellaneous Tests

- 1. Shielding effectiveness tests for various materials
- 2. Bulk injection tests

3. Audio Frequency Conducted Susceptibility
4. Burst & Voltage Dip test
5. Radio frequency equipment electromagnetic disturbance tests
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14. Mode tuned tests
15. Measurement and validation of RF tests
16. Energy efficiency tests
17. Pulse magnetic field test
18. Magnetic field continuous immunity tests



(रजेश कुमार सहकरी / Rajesh Kumar Sehukari)
कॉन्डर (यु.आ./सी.डी. आ.
यु.आ.प.सि./यु.आ.सि. (यु.पो.परि)
DGQA/DCQA (WP)
आ. मंत्रालय, नई दिल्ली-110023
Ministry of Defence, New Delhi-110023



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1	Corrigendum 3 of EMI/EMC Test Facility	Revised List of Test Equipment and legible copy of DTIS Guideline for EMI/EMC test facility of DTIS	10-Nov-2025 03:49 PM	Corrigendum 3 of EMI and EMC test facility.pdf	5472.57